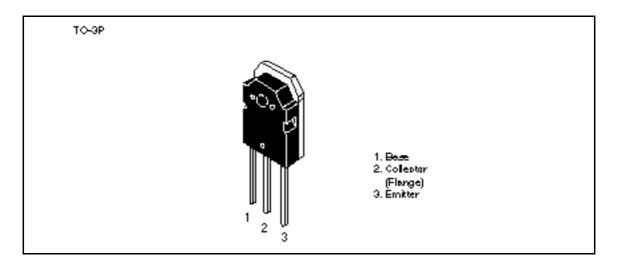
Silicon NPN Triple Diffused

HITACHI

Application

High voltage, high speed and high power switching

Outline





Absolute Maximum Ratings ($Ta = 25^{\circ}C$)

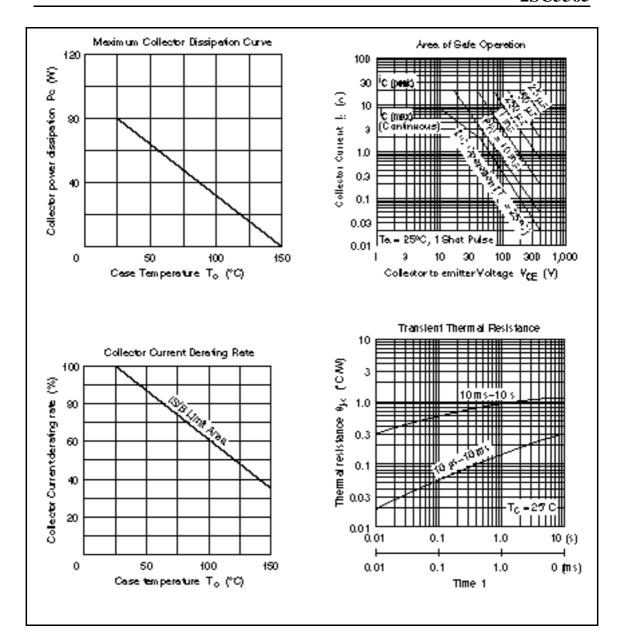
Item	Symbol	Ratings	Unit	
Collector to base voltage	V_{CBO}	500	V	
Collector to emitter voltage	V_{CEO}	400	V	
Emitter to base voltage	V_{EBO}	V _{EBO} 10		
Collector current	I _c	10	Α	
Collector peak current	I _{C(peak)}	20	Α	
Base current	I _B	5	Α	
Collector power dissipation	P _c *1	80	W	
Junction temperature	Tj	150	°C	
Storage temperature	Tstg	-55 to +150	°C	

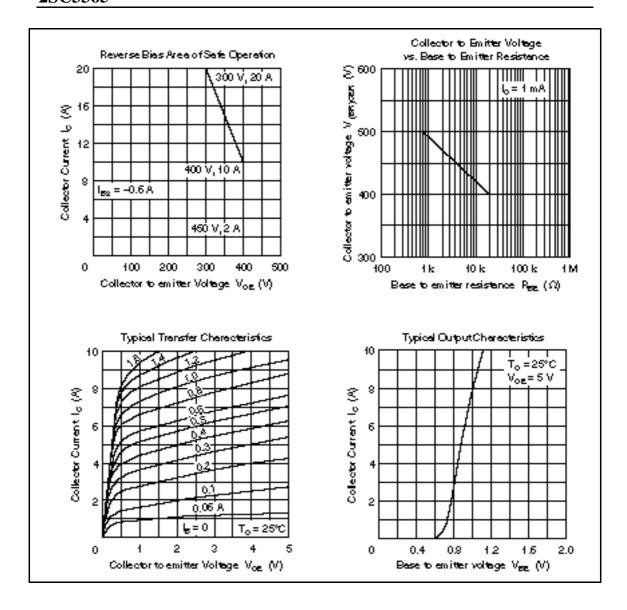
Note: 1. Value at $T_c = 25^{\circ}C$

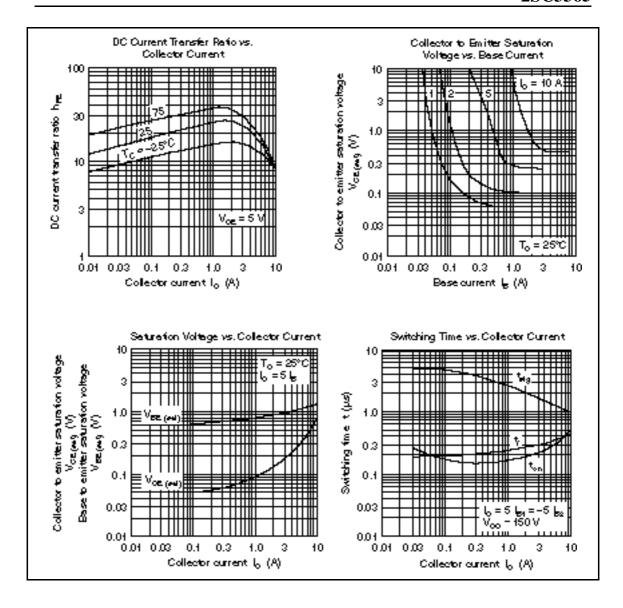
Electrical Characteristics ($Ta = 25^{\circ}C$)

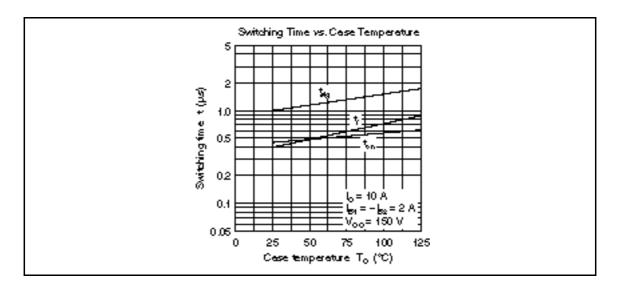
Item	Symbol	Min	Тур	Max	Unit	Test conditions
Collector to emitter sustain	$V_{\text{CEO(sus)}}$	400	_	_	V	$I_{C} = 0.2 \text{ A}, R_{BE} = , L = 100 \text{ mH}$
voltage	$V_{\text{CEX(sus)}}$	400	_	_	V	I_{C} = 10 A, I_{B1} = 2 A, I_{B2} = -0.6 A, V_{BE} = -5.0 V, L = 180 μ H, Clamped
Emitter to base breakdown voltage	$V_{\text{(BR)EBO}}$	10	_	_	V	$I_{E} = 10 \text{ mA}, I_{C} = 0$
Collector cutoff current	I _{CBO}	_	_	50	μΑ	$V_{CB} = 400 \text{ V}, I_{E} = 0$
	I _{CEO}	_	_	50	μΑ	$V_{CE} = 350 \text{ V}, R_{BE} =$
DC current transfer ratio	h _{FE1}	12	_	_		$V_{CE} = 5.0 \text{ V}, I_{C} = 5 \text{ A}^{*1}$
	h _{FE2}	5	_	_		$V_{CE} = 5.0 \text{ V}, I_{C} = 10 \text{ A}^{*1}$
Collector to emitter saturation voltage	$V_{\text{CE(sat)}}$	_	_	1.0	V	$I_{\rm C} = 5 \text{ A}, I_{\rm B} = 1 \text{ A}^{*1}$
Base to emitter saturation voltage	$V_{\text{BE}(\text{sat})}$	_	_	1.5	V	
Turn on time	t _{on}	_	_	1.0	μs	$I_{C} = 10 \text{ A}, I_{B1} = -I_{B2} = 2 \text{ A},$
Storage time	\mathbf{t}_{stg}	_	_	2.5	μs	V _{cc} 150 V
Fall time	t _f	_	_	1.0	μs	_

Note: 1. Pulse test









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